

<b>Notice of References Cited</b>	Application/Control No. 10/676,099		Applicant(s)/Patent Under Reexamination RABACH ET AL.	
	Examiner Anjan K. Deb		Art Unit 2858	Page 1 of 1

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	U	David M. Pozar "Microwave Engineering" page 2, Figure 1.1 The electromagnetic spectrum
	V	IEEE Authoritative Dictionary of IEEE Standard terms, page 41, 7th Edition, IEEE Press
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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